## CERTIFICATE OF MAILING

y that this correspondence and all marked attachments are being deposited with the United States Postal Service as first class mail in an envelope addressed to Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on June 4, 2003.

IN THE LINITED	STATES P	ATFNT AND	TRADEMARK	COFFICE

PATENT APPLICATION

Inventor(s): John STROM

Appln. No.:

10

046,559

Serial No. 个

Series Code ↑ October 27, 2001

Mail Stop AF

Filed:

Hon. Commissioner for Patents

PO Box 1450

1. Small Entity daim

Alexandria, VA 22313-1450

Sir:

**Group Art Unit** 2829

Examiner: Atty. Dkt.

Nguyen, Jimmy

044182 290111 M# Client Ref

Appln. Title: METHOD AND PROCESS OF

APPLYING THE ANALYSIS OF SCRUB

MARK MORPHOLOGY AND LOCATION TO THE EVALUATION

AND TESTING OF SEMICONDUCTOR TESTING, ANALYSIS AND

**MANUFACTURE** 

June 4, 2003 Date:

REPLY/AMENDMENT/LETTER

This is a reply/amendment/letter in the above-identified application and includes the herewith attachment of same date and subjections. which is incorporated hereinto by reference and the signature below is treated as the signature to the attachment in absence signature thereto.

FEE REQUIREMENTS FOR CLAIMS AS AMENDED

1. Small Entity Gaim							
A. ☐ NOT made B. ☐ Withdrawn C. ☐ made herewith D. ☒ made previously  For B & C See Required Separate Paper (Pat-256)	Claims remaining after amendment	Highest nui previously p		Present Extra	Large/Small Entity	Additional Fee	Fee Certle  2 Lg/Sm  00
2. Total Effective Claims	1	**minus	20	0	x \$18/\$9 =	+ \$0	103/203
3. Independent Claims	1	***minus	3	0	x \$84/\$42 =	+ \$0	102/202
4. If amendment enters <u>proper</u> multiple dependent claim(s) into this application for <u>first</u> time (leave blank if this is a <u>reissue</u> application)						`+ \$0	104/204
5. Original due Date: March 4, 2003 NONE						3583	13
6. Petition is hereby made to extend the original due (1 mo) \$110/\$55 =							115/215
date to cover the date this response is filed for which the (2 mos) \$410/\$205 =					. + \$465		116/216
requisite fee is attached			117/217				
		(4	mos)	\$1,450/\$725=			128/228
<u></u>		(5	mos)	\$1,970/\$985=		1	120/220
7. Enter any previous extension fee paid since above original due date and subtract					- \$0		
8.					Extension Fee	+ \$465	
9. If Terminal Disclaimer attached, add Rule 20(d) official fee				+ \$110/\$55	+ \$0	148/248	
10. If IDS attached requires Official Fee under Rule 97 (c),add					+ \$180	+ \$0	126
or if Rule 97(d) Requestadd					+ \$180		126
11. After-Final Request Fee per rules 129(a) and 17(r)				+.\$750/370	+ \$0	146/246	
12. No. of additional inventions for examination per Rule 129(b)					x \$750/375 ea	+ \$0	149/249
13. Request for Continued Examination (RCE)				+ \$750/375	+ \$0	1179/1279	
14. Petition fee for					+ \$0		
15.				TOTAL FEE =	\$465		

17. \*\*If the "Highest number previously paid for" in this space is less than 20, write "20" in this space.

18. \*\*\* If the "Highest number previously paid for" in this space is less than 3, write "3" in this space.

Our Deposit Account No. 03-3975) 290111

(Our Order No. 044182

PAT-120 5/03

filed, or which should have been filed herewith on hereafter relative to this application and the resuld uplicate copy of this sheet is attached.  This CHARGE STATEMENT does not authorize filed.	r concerning paper lting Official Document	t under Rule 20, or credit any overpayment, to o	der Rules <u>missing or ins</u> our Accounting order Nos. sho	sufficiencies only) now or win above, for which purpose a	i
	•	Winthrop LLP ual Property Group			
11682 El Camino Real	By Atty:	Victor J. Castellucci	Reg. No.	43,535	
Suite 200 San Diego, CA 92130-2092 Tel: (619) 234-5000 Atty/Sec: VIC/kac	Sig:	Vale Chllen.	Fax: Tel:	(858) 509-4010 ( <b>858) 509-4007</b>	

NOTE: File this cover sheet in duplicate with PTO receipt (PAT-103A) and attachments

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re the Application of: John STROM

Serial No.: 10/046,559

Filing Date: October 27, 2001

Title: METHOD AND PROCESS OF

APPLYING THE ANALYSIS OF SCRUB MARK MORPHOLOGY

AND LOCATION TO THE

**EVALUATION AND TESTING OF** 

SEMICONDUCTOR TESTING,

ANALYSIS, AND MANUFACTURE

Art Unit: 2829

Examiner: Nguyen, Jimmy

Certificate of Mailing

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first class mail, in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on June 4, 2003

By: Kim A Cabello

Kim A. Cabello

## RESPONSE UNDER 37 C.F.R. §1.111(a)

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Responsive to the Office Action dated December 4, 2003, the time for response having been extended to June 4, 2003, by concurrent petition and payment of fee, please amend the above-identified application as follows:

## In the Claims:

Please amend claim 1 as follows:

1. (Amended) An opto-mechanical workstation for loading and systematically moving wafers and for imaging and analyzing scrub marks; said workstation comprising:

a probe card analyzer;

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